# **Special Issue**

## Terahertz Biomedical Imaging and Detection

### Message from the Guest Editor

Terahertz technology has great potential for use in promising medical technologies of the future. The study of biomedical imaging and detection, based on terahertz technology, will not only provide a foundation for medical technology development, but also enable to observe the biomedical events which can not be reveal using conventional optical technologies. The last decade, a quantum leap in terahertz device technology such as source and detector have enabled the practical applications such as the nondestructive testing and have increased the feasibility of usage in clinic. Therefore, at a time like this, it is necessary to make an issue of practically applicable terahertz biomedical imaging and detection technology including biomedical contents that can be detected by terahertz wave.

#### **Guest Editor**

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#### Deadline for manuscript submissions

closed (31 December 2018)



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## Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

### Editor-in-Chief

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